Notice of References Cited

Application/Control No. 09/736,667
Examiner

Applicant(s)/Patent Under Reexamination FUJII ET AL.

Examiner
Vijay B. Chawan

Art Unit 2654

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,806,025	09-1998	Vis et al.	704/226
	В	US-5,920,834	07-1999	Sih et al.	704/233
	С	US-5,706,395	01-1998	Arslan et al.	704/226
	D	US-5,966,689	10-1999	McCree, Alan V.	704/226
	Е	US-6,782,360	08-2004	Gao et al.	704/222
	F	US-5,742,694	04-1998	Eatwell, Graham P.	381/94.2
	G	US-5,590,241	12-1996	Park et al.	704/227
	Н	US-4,860,355	08-1989	Copperi, Maurizio	704/213
	ı	US-6,683,960	01-2004	Fujii et al.	381/71.8
	J	US-5,963,899	10-1999	Bayya et al.	704/226
	к	US-4,301,329	11-1981	Taguchi, Tetsu	704/217
	L	US-4,538,234	08-1985	Honda et al.	704/229
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			- No. 100 pt 1		
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

HONA ALENI DOCUMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	٧						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.